

# STATS305B – Lecture 6

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## 1 Model diagnostics in logistic regression

### 1.1 Grouped goodness-of-fit-tests

If our covariates  $X$  are grouped (for instance  $X$  is categorical), then we can use a  $G^2$  or  $X^2$  statistic to measure our model's goodness-of-fit. If we do not have groups, then we can create groups by partitioning the feature space. These goodness-of-fit tests are measuring variation in the counts that is unexplained by our model.

### 1.2 Pearson's residuals

Define the Pearson's residuals to be,

$$e_i = \frac{Y_i - \hat{\pi}_i}{\sqrt{\hat{\pi}_i(1 - \hat{\pi}_i)}}.$$

If the model is true and if we wrote  $\pi_i$  instead of  $\hat{\pi}_i$ , then the above residuals would be independent and with mean 0 and variance 1. But  $\hat{\pi}_i$  is fit to  $Y$ , and so  $e_i$  may be dependent and have variance less than 1. The residuals are used in *Pearson's  $\chi^2$  statistic*,

$$X^2 = \sum_{i=1}^n e_i^2.$$

The statistic  $X^2$  can be used as an alternative to the deviance.

### 1.3 Deviance residuals

An alternative to the Pearson's residuals is to use the decomposition,

$$\text{DEV}(\hat{\pi}|Y) = \sum_{i=1}^n \text{DEV}(\hat{\pi}_i|Y_i),$$

where  $\text{DEV}(\hat{\pi}_i|Y_i) = -2(Y_i \log(\hat{\pi}_i) + (1 - Y_i) \log(1 - \hat{\pi}_i))$  in the binary case. The *deviance residuals* are defined to be,

$$\text{sign}(Y_i - \hat{\pi}_i) \sqrt{\text{DEV}(\hat{\pi}_i|Y_i)}.$$

### 1.4 Standardized residuals and hat matrices

Is there a way to adjust Pearson's residuals so that they have variance 1? In ordinary least squares regression, we know that

$$r_i = \frac{Y_i - \hat{Y}_i}{\sqrt{R_{ii}}},$$

have variance  $\sigma^2$ . Where  $R$  is the orthogonal projection onto the orthogonal complement of the range of  $X$ . That is,  $R = I - X(X^T X)^{-1} X^T = I - H$ . Can we find something analogous to the hat matrix in logistic regression? Recall that,

$$\hat{\beta} - \beta^* \approx (X^T W_{\beta^*} X)^{-1} X^T (Y - \pi_{\beta^*}(X)) = (\tilde{X}^T \tilde{X})^{-1} \tilde{X}^T R_{\beta^*}(X, Y),$$

where  $\tilde{X} = W_{\beta^*}(X)^{1/2} X$  and  $R_{\beta^*}(X, Y) = W_{\beta^*}(X)^{-1/2} (Y - \pi_{\beta^*}(X))$ . Thus, logistic regression looks like weighted least squares. Recall the in weighted least squares we use the estimator,

$$\hat{\beta}_W = \underset{\beta}{\text{argmin}} \left\{ \sum_{i=1}^n W_i (Y_i - X_i^T \beta)^2 \right\}.$$

If  $\tilde{X} = W^{1/2} X$  and  $\tilde{Y} = W^{1/2} Y$ , then

$$\hat{\beta}_W = \underset{\beta}{\text{argmin}} \left\{ \sum_{i=1}^n (\tilde{Y}_i - \tilde{X}_i^T \beta)^2 \right\} = (\tilde{X}^T \tilde{X})^{-1} \tilde{X}^T \tilde{Y}.$$

The vector  $R_{\beta^*}(X, Y) = W_{\beta^*}(X)^{-1/2} (Y - \pi_{\beta^*}(X))$  has independent entries with mean 0 and variance 1. Thus, when viewing logistic regression as weighted least squares, the appropriate hat matrix is,

$$H_{\beta^*} = \tilde{X} (\tilde{X}^T \tilde{X})^{-1} \tilde{X}^T = W_{\beta^*}(X)^{1/2} X (X^T W_{\beta^*}(X) X)^{-1} X^T W_{\beta^*}(X)^{1/2}.$$

Which we have to estimate with,

$$H_{\hat{\beta}} = W_{\hat{\beta}}(X)^{1/2} X (X^T W_{\hat{\beta}}(X) X)^{-1} X^T W_{\hat{\beta}}(X)^{1/2}.$$

Thus, the standardized residuals are,

$$r_i = \frac{e_i}{\sqrt{1 - H_{\hat{\beta}, ii}}}.$$

These residuals are the leverage scores  $H_{\hat{\beta}, ii}$  can be used similarly to how they are used in OLS.

### 1.5 Analogies of $R^2$

In OLS, we have  $R^2 = \frac{SST - SSE}{SST}$ . The analog for logistic regression is thus,

$$R^2 = \frac{\text{DEV}(M_0) - \text{DEV}(M)}{\text{DEV}(M_0)},$$

where  $M$  is our model and  $M_0$  is the model with just an intercept.

## 1.6 Confusion matrices and AUC

So far we have been modelling  $\pi(x) = \mathbb{P}(Y|X = x)$  via  $\hat{\pi}(x)$ . To make a prediction  $\hat{y}(x) \in \{0, 1\}$ , we can pick a threshold  $c$  and define,

$$\hat{y}(x) = \begin{cases} 1 & \text{if } \hat{\pi}(x) \geq c, \\ 0 & \text{if } \hat{\pi}(x) < c. \end{cases}$$

For each fixed  $c$ , we can create a *confusion matrix* that records the number of correct and incorrect predictions and the predicted values. The confusion matrix looks like this,

		Actual	
		0	1
Fitted	0	True negative (TN)	False negative (FN)
	1	False positive (TP)	True positive (TP)

From this we can calculate the true positive rate (TPR) and the false positive rate (FPR). These are,

$$TPR = \frac{TP}{TP + FN}, \quad FPR = \frac{FP}{FP + TN}.$$

Ideally we would have  $TPR \approx 1$  and  $FPR \approx 0$ , but it can be hard to achieve both simultaneously. Both TPR and FPR are functions of our chosen threshold  $c$ . By plotting the pair  $(FPR, TPR)$  as  $c$  varies from 0 to 1, we produce an ROC curve. We can measure our classifier by how far the ROC curve is above the line  $y = x$ . This can be summarized by the AUC which is the area under the ROC curve. A random assignment of 0 and 1 to  $\hat{y}$  would give a curve with  $AUC = 0.5$ .

## 1.7 Model selection

We can use the AIC to select models. The AIC of a model  $M$  with  $p(M)$  parameters is defined to be

$$\begin{aligned} AIC(M) &= -2 \log L(M) + 2p(M) \\ &= \text{DEV}(M) + 2p(M) + 2g(Y), \end{aligned}$$

where  $L(M)$  is the maximized likelihood of the data under the model  $M$ . We also have the BIC which is,

$$BIC(M) = -2 \log L(M) + \log(n)p(M).$$

We can then choose a model by picking the one which minimizes  $AIC(M)$  or  $BIC(M)$ . The AIC is a generalization of Mallows's  $C_p$  statistic and the B in BIC stands for Bayesian. A warning: if AIC or BIC or something else is used to pick a model  $M$ , then all the inference results we derived no longer hold. This is because we are using the data twice. Once to pick the model but then again to do inference. For the inference results, the model was chosen separately to the data.

## 2 Generalized linear models

Suppose that,

$$f(y|\theta) = \alpha(\theta)b(y)\exp(yQ(\theta)),$$

where,

$$\alpha(\theta) = \int_{\mathcal{Y}} \exp(yQ(\theta))b(y)m(dy).$$

This means that our data  $y$  comes from an exponential family with sufficient statistic  $y$ , natural parameters  $\eta = Q(\theta)$  and reference measure  $m$  with density  $b(y)$ . We can write,

$$\alpha(\theta)^{-1} = \exp(\Lambda(\eta)) = \int_{\mathcal{Y}} \exp(y\eta) b(y) m(dy).$$

Standard calculations give,

$$\nabla \Lambda(\eta) = \mathbb{E}_{\eta}[Y],$$

and

$$\nabla^2 \Lambda(\eta) = \text{Var}_{\eta}(Y).$$

Thus, the function  $\eta \mapsto \mathbb{E}_{\eta}[Y]$  is increasing and invertible on its range. It follows that  $\text{Var}_{\eta}(Y)$  can be written as a function of  $\eta = (\nabla \Lambda)^{-1}(\mathbb{E}_{\eta}[Y])$ . Thus,  $\text{Var}(Y) = V(\mu)$  where  $V$  is a function and  $\mu = \mathbb{E}_{\eta}[Y]$ . Here are some examples,

1. Poisson: If  $Y \sim \text{Poisson}(\mu)$ , then

$$P_{\mu}(Y = y) = \exp(y \log(\mu)) \frac{e^{-\mu}}{y!}.$$

The natural parameter is  $\log(\mu)$  and here  $\text{Var}_{\mu}(Y) = \mu = V(\mu) = V(\mathbb{E}_{\mu}[Y])$ . The natural regression model is  $\log(\mu_i) = X_i^T \beta$ .

2. Bernoulli: If  $Y \sim \text{Bernoulli}(\pi)$ , then

$$P_{\pi}(Y = y) = \exp(y \log(\pi) + (1 - y) \log(1 - \pi)) = \exp(y \log(\pi/(1 - \pi)) - \log(1 - \pi)).$$

Thus, the natural parameter is  $\eta = \log(\pi/(1 - \pi))$ , and we have our familiar logistic regression model. In this case,  $\text{Var}_{\pi}(Y) = \pi(1 - \pi) = V(\pi) = V(\mathbb{E}_{\pi}(Y))$ .